

Sample &

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## DRV8412, DRV8432

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## DRV84x2 Dual Full-Bridge PWM Motor Driver

Technical

Documents

## 1 Features

- High-Efficiency Power Stage (up to 97%) With Low  $R_{DS(on)}$  MOSFETs (110 m $\Omega$  at  $T_J = 25^{\circ}C$ )
- Operating Supply Voltage up to 52 V
- DRV8412 (Power Pad Down): up to 2 × 3-A Continuous Output Current (2 × 6-A Peak) in Dual Full-Bridge Mode or 6-A Continuous Current in Parallel Mode (12-A Peak)
- DRV8432 (Power Pad Up): up to 2 × 7-A Continuous Output Current (2 × 12-A Peak) in Dual Full-Bridge Mode or 14-A Continuous Current in Parallel Mode (24-A Peak)
- PWM Operating Frequency up to 500 kHz
- Integrated Self-Protection Circuits Including Undervoltage, Overtemperature, Overload, and Short Circuit
- Programmable Cycle-by-Cycle Current Limit
   Protection
- Independent Supply and Ground Pins for Each Half Bridge
- Intelligent Gate Drive and Cross Conduction
   Prevention
- No External Snubber or Schottky Diode is Required

## 2 Applications

- Brushed DC and Stepper Motors
- Three-Phase Permanent Magnet Synchronous Motors
- Robotic and Haptic Control System
- Actuators and Pumps
- Precision Instruments
- TEC Drivers
- LED Lighting Drivers

## **3** Description

The DRV841x2 are high-performance, integrated dual full-bridge motor driver with an advanced protection system.

Because of the low  $R_{DS(on)}$  of the H-Bridge MOSFETs and intelligent gate drive design, the efficiency of these motor drivers can be up to 97%. This high efficiency enables the use of smaller power supplies and heatsinks, and the devices are good candidates for energy-efficient applications. The DRV841x2 requires two power supplies, one at 12 V for GVDD and VDD, and another up to 50 V for PVDD. The DRV841x2 can operate at up to 500-kHz switching frequency while still maintaining precise control and high efficiency. The devices also have an innovative protection system safeguarding the device against a wide range of fault conditions that could damage the system. These safeguards are short-circuit protection, overcurrent protection, undervoltage protection, and two-stage thermal protection. The DRV841x2 has a current-limiting circuit that prevents device shutdown during load transients such as motor start-up. A programmable overcurrent detector allows adjustable current limit and protection level to meet different motor requirements.

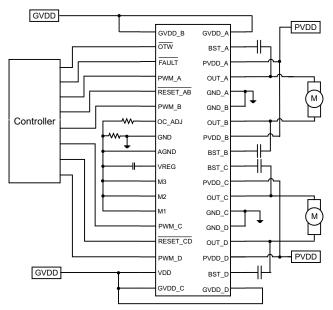
The DRV841x2 has unique independent supply and ground pins for each half-bridge. These pins make it possible to provide current measurement through external shunt resistor and support multiple motors with different power supply voltage requirements.

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
DRV8412	HTSSOP (44)	14.00 mm x 6.10 mm
DRV8432	HSSOP (36)	15.90 mm x 11.00 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

## Simplified Application Diagram



**A** 

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## **4** Revision History

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NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

## Changes from Revision F (January 2014) to Revision G

•	Added ESD Ratingstable, Feature Description section, Device Functional Modes, Application and Implementation
	section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and
	Mechanical, Packaging, and Orderable Information section1

## Changes from Revision E (October 2013) to Revision F

•	Changed GND_A, GND_B, GND_C, and GND_D pins description to remove text "requires close decoupling	
	capacitor to ground"	4
•	Changed the t <sub>ON_MIN</sub> description to include "for charging the Bootstrap capacitor"	6
•	Added text to the Overcurrent (OC) Protection section - "It is important to note" 1	3

## Changes from Revision D (July 2011) to Revision E

•	Added last sentence in description of Thermal Pad in Pin Functions table
•	Added THERMAL INFORMATION table
•	Added a new paragraph in DIFFERENT OPERATIONAL MODES section: In operation modesDC logic level

## Changes from Revision C (May 2010) to Revision D

•	Changed from 80 m $\Omega$ to 110 m $\Omega$ in first Feature	1
•	Changed from 50 V to 52 V in second Feature	1
•	Deleted (70 V Absolute Maximum) from second Feature	
•	Added LED Lighting Drivers to Applications	1
•	Added Includes metallization bond wire and pin resistance to R <sub>DS(on)</sub> test conditions	8
•	Changed $R_{DS(on)}$ typ from 80 m $\Omega$ to 110 m $\Omega$	

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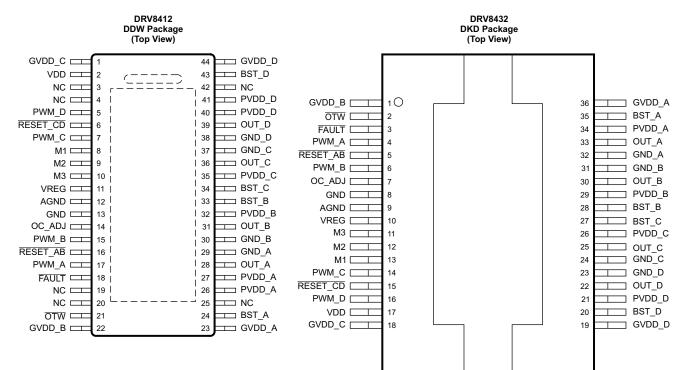
•	Added text to 5th paragraph of Overcurrent (OC) Protection section	. 13
•	Deleted Output Inductor Selection section and moved information into Overcurrent (OC) Protection section	. 13
•	Changed Figure 8	17
•	Changed Figure 16	21
•	Deleted Application Diagram Example for Three Phase PMSM PVDD Sense Operation and Application Diagram Example for Three Phase PMSM GND Sense Operation figures	. 22
•	Added Figure 18	23
•	Changed Figure 20	28

## Changes from Revision B (Jan 2010) to Revision C

nanges from Revision A (December 2009) to Revision B	age	
Deleted or GVDD undervoltage from DEVICE RESET section second paragraph	. 14	
Added second paragraph to Bootstrap Capacitor section	12	
Added Thermal Pad and Heat slug rows to end of Pin Functions table. Also added T=thermal in note	5	
Changed DRV8432 pinout	4	
Deleted all DRV8422 related descriptions from this data sheet	1	
	Changed DRV8432 pinout Added Thermal Pad and Heat slug rows to end of Pin Functions table. Also added T=thermal in note Added second paragraph to Bootstrap Capacitorsection Deleted or GVDD undervoltage from DEVICE RESET section second paragraph	Deleted all DRV8422 related descriptions from this data sheet

•	Added T <sub>A</sub> = 125°C power rating of 1.0 W to package power deratings table
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## 5 Pin Configuration and Functions



#### **Pin Functions**

PIN			I/O TYPE <sup>(1)</sup>	DECODIDION
NAME	DRV8412	DRV8432	DESCRIPTION	DESCRIPTION
AGND	12	9	Р	Analog ground
BST_A	24	35	Р	High side bootstrap supply (BST), external capacitor to OUT_A required
BST_B	33	28	Р	High side bootstrap supply (BST), external capacitor to OUT_B required
BST_C	34	27	Р	High side bootstrap supply (BST), external capacitor to OUT_C required
BST_D	43	20	Р	High side bootstrap supply (BST), external capacitor to OUT_D required
GND	13	8	Р	Ground
GND_A	29	32	Р	Power ground for half-bridge A
GND_B	30	31	Р	Power ground for half-bridge B
GND_C	37	24	Р	Power ground for half-bridge C
GND_D	38	23	Р	Power ground for half-bridge D
GVDD_A	23	36	Р	Gate-drive voltage supply
GVDD_B	22	1	Р	Gate-drive voltage supply
GVDD_C	1	18	Р	Gate-drive voltage supply
GVDD_D	44	19	Р	Gate-drive voltage supply
M1	8	13	I	Mode selection pin
M2	9	12	I	Mode selection pin
M3	10	11	I	Reserved mode selection pin, AGND connection is recommended
NC	3, 4, 19, 20, 25, 42	—	—	No connection pin. Ground connection is recommended
OC_ADJ	14	7	0	Analog overcurrent programming pin, requires resistor to AGND
OTW	21	2	0	Overtemperature warning signal, open-drain, active-low. An internal pullup resistor to VREG (3.3 V) is provided on output. Level compliance for 5-V logic can be obtained by adding external pullup resistor to 5 V
OUT_A	28	33	0	Output, half-bridge A
OUT_B	31	30	0	Output, half-bridge B
OUT_C	36	25	0	Output, half-bridge C

(1) I = input, O = output, P = power, T = thermal



## Pin Functions (continued)

PIN			DECODIDION	
NAME	DRV8412	DRV8432	I/O TYPE <sup>(1)</sup>	DESCRIPTION
OUT_D	39	22	0	Output, half-bridge D
PVDD_A	26, 27	34	Р	Power supply input for half-bridge A requires close decoupling capacitor to ground.
PVDD_B	32	29	Р	Power supply input for half-bridge B requires close decoupling capacitor to gound.
PVDD_C	35	26	Р	Power supply input for half-bridge C requires close decoupling capacitor to ground.
PVDD_D	40, 41	21	Р	Power supply input for half-bridge D requires close decoupling capacitor to ground.
PWM_A	17	4	I	Input signal for half-bridge A
PWM_B	15	6	I	Input signal for half-bridge B
PWM_C	7	14	I	Input signal for half-bridge C
PWM_D	5	16	I	Input signal for half-bridge D
RESET_AB	16	5	I	Reset signal for half-bridge A and half-bridge B, active-low
RESET_CD	6	15	I	Reset signal for half-bridge C and half-bridge D, active-low
FAULT	18	3	0	Fault signal, open-drain, active-low. An internal pullup resistor to VREG (3.3 V) is provided on output. Level compliance for 5-V logic can be obtained by adding external pullup resistor to 5 V
VDD	2	17	Р	Power supply for digital voltage regulator requires capacitor to ground for decoupling.
VREG	11	10	Р	Digital regulator supply filter pin requires 0.1-µF capacitor to AGND.
THERMAL PAD	_	N/A	Т	Solder the exposed thermal pad to the landing pad on the pcb. Connect landing pad to bottom side of pcb through via for better thermal dissipation. This pad should be connected to GND.
HEAT SLUG	N/A	—	Т	Mount heat sink with thermal interface on top of the heat slug for best thermal performance.

## **Mode Selection Pins**

I	MODE PINS		OUTPUT	DESCRIPTION		
М3	M2	M1	CONFIGURATION	DESCRIPTION		
0	0	0	2 FB or 4 HB	Dual full bridges (two PWM inputs each full bridge) or four half bridges with cycle-by-cycle current limit		
0	0	1	2 FB or 4 HB	Dual full bridges (two PWM inputs each full bridge) or four half bridges with OC latching shutdown (no cycle-by-cycle current limit)		
0	1	0	1 PFB	Parallel full bridge with cycle-by-cycle current limit		
0	1	1	2 FB	Dual full bridges (one PWM input each full bridge with complementary PWM on second half bridge) with cycle-by-cycle current limit		
1	х	x	Reserved			



## 6 Specifications

## 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

	MIN	MAX	UNIT
VDD to GND	-0.3	13.2	V
GVDD_X to GND	-0.3	13.2	V
PVDD_X to GND_X <sup>(2)</sup>	-0.3	70	V
OUT_X to GND_X <sup>(2)</sup>	-0.3	70	V
BST_X to GND_X <sup>(2)</sup>	-0.3	80	V
Transient peak output current (per pin), pulse width limited by internal overcurrent protection circuit		16	А
Transient peak output current for latch shut down (per pin)		20	А
VREG to AGND	-0.3	4.2	V
GND_X to GND	-0.3	0.3	V
GND to AGND	-0.3	0.3	V
PWM_X to GND	-0.3	V <sub>REG</sub> + 0.5	V
OC_ADJ, M1, M2, M3 to AGND	-0.3	4.2	V
RESET_X, FAULT, OTW to GND	-0.3	7	V
Continuous sink current (FAULT, OTW)		9	mA
Operating junction temperature, T <sub>J</sub>	-40	150	°C
Storage temperature, T <sub>stg</sub>	-55	150	

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) These are the maximum allowed voltages for transient spikes. Absolute maximum DC voltages are lower.

## 6.2 ESD Ratings

			VALUE	UNIT
V <sub>(ESD)</sub>	Electrostatic discharge	Charged device model (CDM), per JEDEC specification JESD22-C101, all $\ensuremath{pins^{(1)}}$	±1500	V

(1) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

## 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
PVDD_X	Half bridge X (A, B, C, or D) DC supply voltage	0	50	52.5	
GVDD_X	Supply for logic regulators and gate-drive circuitry	10.8	12	13.2	V
VDD	Digital regulator supply voltage	10.8	12	13.2	
I <sub>O_PULSE</sub>	Pulsed peak current per output pin (could be limited by thermal)			15	А
lo	Continuous current per output pin (DRV8432)			9	mA
F <sub>SW</sub>	PWM switching frequency			500	kHz
R <sub>OCP_CBC</sub>	OC programming resistor range in cycle-by-cycle current limit modes	24		200	kΩ
R <sub>OCP_OCL</sub>	OC programming resistor range in OC latching shutdown modes	22		200	K12
C <sub>BST</sub>	Bootstrap capacitor range	33		220	nF
t <sub>ON_MIN</sub>	Minimum PWM pulse duration, low side, for charging the Bootstrap capacitor		50		ns
T <sub>A</sub>	Operating ambient temperature	-40		85	°C



## 6.4 Thermal Information

		DRV8412	DRV8432	
	THERMAL METRIC <sup>(1)</sup>	DDW PACKAGE	DKD PACKAGE	UNIT
		44 PINS	36 PINS	
$R_{ extsf{ heta}JA}$	Junction-to-ambient thermal resistance	24.5	13.3 (with heat sink)	
R <sub>0JC(top)</sub>	Junction-to-case (top) thermal resistance	7.8	0.4	
$R_{\theta JB}$	Junction-to-board thermal resistance	5.5	13.3	°C/W
Ψ <sub>JT</sub>	Junction-to-top characterization parameter	0.1	0.4	
$\Psi_{JB}$	Junction-to-board characterization parameter	5.4	13.3	
R <sub>0JC(bot)</sub>	Junction-to-case (bottom) thermal resistance	0.2	N/A	

(1) for more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

## 6.5 Package Heat Dissipation Ratings

PARAMETER	DRV8412	DRV8432
$R_{\mbox{\thetaJC}},$ junction-to-case (power pad / heat slug) thermal resistance	1.1 °C/W	0.9 °C/W
$R_{\theta JA}$ , junction-to-ambient thermal resistance	25 °C/W	This device is not intended to be used without a heatsink. Therefore, $R_{\theta,JA}$ is not specified. See the <i>Thermal Information</i> section.
Exposed power pad / heat slug area	34 mm <sup>2</sup>	80 mm <sup>2</sup>

## 6.6 Package Power Deratings (DRV8412)<sup>(1)</sup>

PACKAGE	T <sub>A</sub> = 25°C POWER RATING	DERATING FACTOR ABOVE $T_A = 25^{\circ}C$	T <sub>A</sub> = 70°C POWER RATING	T <sub>A</sub> = 85°C POWER RATING	T <sub>A</sub> = 125°C POWER RATING
44-PIN TSSOP (DDW)	5.0 W	40.0 mW/°C	3.2 W	2.6 W	1.0 W

(1) Based on EVM board layout

## DRV8412, DRV8432

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STRUMENTS

**EXAS** 

## 6.7 Electrical Characteristics

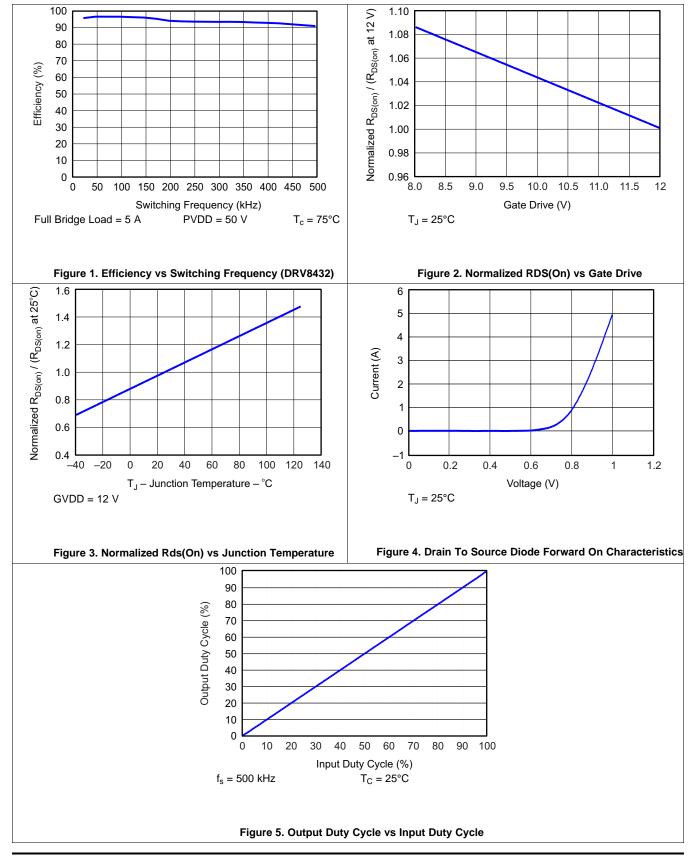
 $T_A = 25 \text{ °C}$ , PVDD = 50 V, GVDD = VDD = 12 V,  $f_{Sw} = 400 \text{ kHz}$ , unless otherwise noted. All performance is in accordance with recommended operating conditions unless otherwise specified.

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
INTERNAL VOL	TAGE REGULATOR AND CURRENT CONSUMPTION	N				
V <sub>REG</sub>	Voltage regulator, only used as a reference node	VDD = 12 V	2.95	3.3	3.65	V
		Idle, reset mode		9	12	mA
I <sub>VDD</sub>	VDD supply current	Operating, 50% duty cycle		10.5		
		Reset mode		1.7	2.5	mA
GVDD_X	Gate supply current per half-bridge	Operating, 50% duty cycle		8		
I <sub>PVDD_X</sub>	Half-bridge X (A, B, C, or D) idle current	Reset mode		0.7	1	mA
OUTPUT STAG	E					
D	MOSFET drain-to-source resistance, low side (LS)	$T_J = 25^{\circ}C$ , GVDD = 12 V, Includes metallization bond wire and pin resistance		110		
R <sub>DS(on)</sub>	MOSFET drain-to-source resistance, high side (HS)	$T_J = 25^{\circ}$ C, GVDD = 12 V, Includes metallization bond wire and pin resistance		110		mΩ
V <sub>F</sub>	Diode forward voltage drop	T <sub>J</sub> = 25°C - 125°C, I <sub>O</sub> = 5 A		1		V
t <sub>R</sub>	Output rise time	Resistive load, $I_0 = 5 A$		14		
t <sub>F</sub>	Output fall time	Resistive load, $I_0 = 5 A$		14		
t <sub>PD_ON</sub>	Propagation delay when FET is on	Resistive load, $I_0 = 5 A$		38		ns
t <sub>PD_OFF</sub>	Propagation delay when FET is off	Resistive load, $I_0 = 5 A$		38		
t <sub>DT</sub>	Dead time between HS and LS FETs	Resistive load, $I_0 = 5 A$		5.5		
I/O PROTECTIC	DN					
V <sub>uvp,G</sub>	Gate supply voltage GVDD_X undervoltage protection threshold			8.5		V
V <sub>uvp,hyst</sub> <sup>(1)</sup>	Hysteresis for gate supply undervoltage event			0.8		
OTW <sup>(1)</sup>	Overtemperature warning		115	125	135	
OTW <sub>hyst</sub> <sup>(1)</sup>	Hysteresis temperature to reset OTW event			25		
OTSD <sup>(1)</sup>	Overtemperature shut down			150		
OTE- OTW <sub>differential</sub> <sup>(1)</sup>	OTE-OTW overtemperature detect temperature difference			25		°C
OTSD <sub>HYST</sub> <sup>(1)</sup>	Hysteresis temperature for FAULT to be released following an OTSD event			25		
I <sub>OC</sub>	Overcurrent limit protection	Resistor—programmable, nominal, $R_{OCP} = 27 \text{ k}\Omega$		9.7		А
I <sub>OCT</sub>	Overcurrent response time	Time from application of short condition to Hi-Z of affected FET(s)		250		ns
R <sub>PD</sub>	Internal pulldown resistor at the output of each half- bridge	Connected when RESET_AB or RESET_CD is active to provide bootstrap capacitor charge		1		kΩ
STATIC DIGITA	L SPECIFICATIONS					
V <sub>IH</sub>	High-level input voltage	PWM_A, PWM_B, PWM_C, PWM_D, M1, M2, M3	2		3.6	
V <sub>IH</sub>	High-level input voltage	RESET_AB, RESET_CD	2		5.5	v
VIL	Low-level input voltage	PWM_A, PWM_B, PWM_C, PWM_D, M1, M2, M3, RESET_AB, RESET_CD			0.8	·
l <sub>lkg</sub>	Input leakage current		-100		100	μA
OTW / FAULT						
R <sub>INT_PU</sub>	Internal pullup resistance, OTW to VREG, FAULT to VREG		20	26	35	kΩ
V <sub>OH</sub>	High-level output voltage	Internal pullup resistor only	2.95	3.3	3.65	
		External pullup of 4.7 kΩ to 5 V	4.5		5	V
V <sub>OL</sub>	Low-level output voltage	$I_0 = 4 \text{ mA}$		0.2	0.4	

(1) Specified by design



## 6.8 Typical Characteristics



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## 7 Detailed Description

## 7.1 Overview

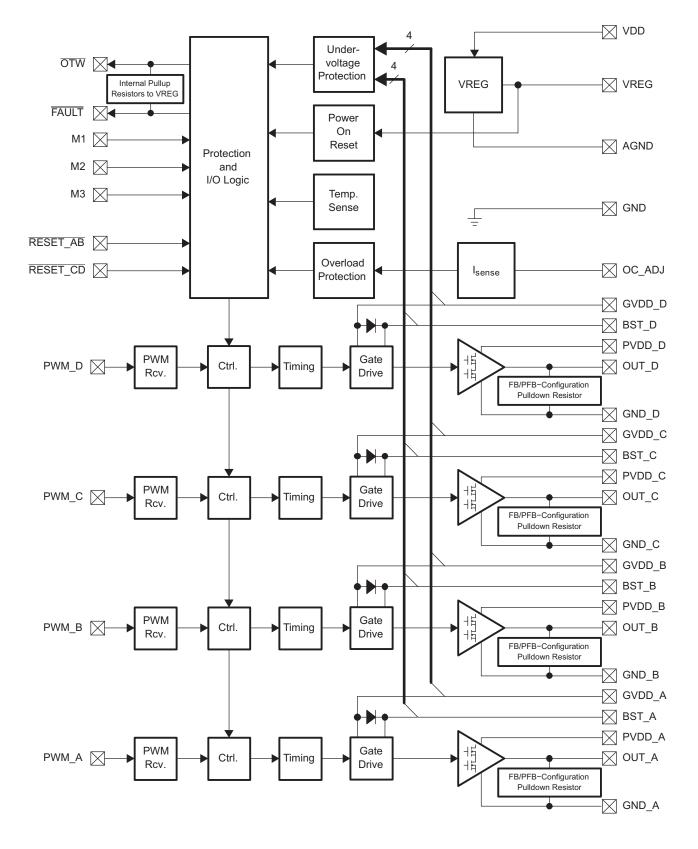
The DRV841x2 is a high performance, integrated dual full bridge motor driver with an advanced protection system.

Because of the low  $R_{DS(on)}$  of the H-Bridge MOSFETs and intelligent gate drive design, the efficiency of these motor drivers can be up to 97%, which enables the use of smaller power supplies and heatsinks, and are good candidates for energy efficient applications.

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## 7.2 Functional Block Diagram





## 7.3 Feature Description

## 7.3.1 Error Reporting

The FAULT and OTW pins are both active-low, open-drain outputs. Their function is for protection-mode signaling to a PWM controller or other system-control device.

Any fault resulting in device shutdown, <u>such</u> as overtemperatue shutd<u>own</u>, overcurrent shutdown, or undervoltage protection, is signaled by the FAULT pin going low. Likewise, OTW goes low when the device junction temperature exceeds 125°C (see Table 1).

## Table 1. Protection Mode Signal Descriptions

FAULT	OTW	DESCRIPTION
0	0	Overtemperature warning and (overtemperature shut-down or overcurrent shut-down or undervoltage protection) occurred
0	1	Overcurrent shut-down or GVDD undervoltage protection occurred
1	0	Overtemperature warning
1	1	Device under normal operation

TI recommends monitoring the OTW signal using the system microcontroller and responding to an OTW signal by reducing the load current to prevent further heating of the device resulting in device overtemperature shutdown (OTSD).

To reduce external component count, an internal pullup resistor to VREG (3.3 V) is provided on both FAULT and OTW outputs. Level compliance for 5-V logic can be obtained by adding external pullup resistors to 5 V (see the *Electrical Characteristics* section of this data sheet for further specifications).

## 7.3.2 Device Protection System

The DRV841x2 contains advanced protection circuitry carefully designed to facilitate system integration and ease of use, as well as to safeguard the device from permanent failure due to a wide range of fault conditions such as short circuits, overcurrent, overtemperature, and undervoltage. The DRV841x2 responds to a fault by immediately setting the half bridge outputs in a high-impedance (Hi-Z) state and asserting the FAULT pin low. In situations other than overcurrent or overtemperature, the device automatically recovers when the fault condition has been removed or the gate supply voltage has increased. For highest possible reliability, reset the device externally no sooner than 1 second after the shutdown when recovering from an overcurrent shut down (OCSD) or OTSD fault.

## 7.3.2.1 Bootstrap Capacitor Undervoltage Protection

When the device runs at a low switching frequency (for example, less than 10 kHz with a 100-nF bootstrap capacitor), the bootstrap capacitor voltage might not be able to maintain a proper voltage level for the high-side gate driver. A bootstrap capacitor undervoltage protection circuit (BST\_UVP) will prevent potential failure of the high-side MOSFET. When the voltage on the bootstrap capacitors is less than the required value for safe operation, the DRV841x2 will initiate bootstrap capacitor recharge sequences (turn off high side FET for a short period) until the bootstrap capacitors are properly charged for safe operation. This function may also be activated when PWM duty cycle is too high (for example, less than 20 ns off time at 10 kHz). Note that bootstrap capacitor might not be able to be charged if no load or extremely light load is presented at output during BST\_UVP operation, so it is recommended to turn on the low side FET for at least 50 ns for each PWM cycle to avoid BST\_UVP operation if possible.

For applications with lower than 10-kHz switching frequency and not to trigger BST\_UVP protection, a larger bootstrap capacitor can be used (for example, 1- $\mu$ F capacitor for 800-Hz operation). When using a bootstrap cap larger than 220 nF, it is recommended to add 5- $\Omega$  resistors between 12-V GVDD power supply and GVDD\_X pins to limit the inrush current on the internal bootstrap circuitry.

## 7.3.2.2 Overcurrent (OC) Protection

The DRV841x2 has independent, fast-reacting current detectors with programmable trip threshold (OC threshold) on all high-side and low-side power-stage FETs. There are two settings for OC protection through mode selection pins: cycle-by-cycle (CBC) current limiting mode and OC latching (OCL) shut down mode.



## Feature Description (continued)

In CBC current limiting mode, the detector outputs are monitored by two protection systems. The first protection system controls the power stage in order to prevent the output current from further increasing, that is, it performs a CBC current-limiting function rather than prematurely shutting down the device. This feature could effectively limit the inrush current during motor start-up or transient without damaging the device. During short to power and short to ground conditions, the current limit circuitry might not be able to control the current to a proper level, a second protection system triggers a latching shutdown, resulting in the related half bridge being set in the high-impedance (Hi-Z) state. Current limiting and overcurrent protection are independent for half-bridges A, B, C, and, D, respectively.

Figure 6 illustrates cycle-by-cycle operation with high side OC event and Figure 7 shows cycle-by-cycle operation with low side OC. Dashed lines are the operation waveforms when no CBC event is triggered and solid lines show the waveforms when CBC event is triggered. In CBC current limiting mode, when low side FET OC is detected, the device will turn off the affected low side FET and keep the high side FET at the same half bridge off until the next PWM cycle; when high side FET OC is detected, the device will turn off the affected high side FET and turn on the low side FET at the half bridge until next PWM cycle.

It is important to note that if the input to a half bridge is held to a constant value when an over current event occurs in CBC, then the associated half bridge will be in a HI-Z state upon the over current event ending. Cycling IN\_X will allow OUT\_X to resume normal operation.

In OC latching shut down mode, the CBC current limit and error recovery circuits are disabled and an overcurrent condition will cause the device to shutdown immediately. After shutdown, RESET\_AB and/or RESET\_CD must be asserted to restore normal operation after the overcurrent condition is removed.

For added flexibility, the OC threshold is programmable using a single external resistor connected between the OC\_ADJ pin and GND pin. See Table 2 for information on the correlation between programming-resistor value and the OC threshold. The values in Table 2 show typical OC thresholds for a given resistor. Assuming a fixed resistance on the OC\_ADJ pin across multiple devices, a 20% device-to-device variation in OC threshold measurements is possible. Therefore, this feature is designed for system protection and not for precise current control. It should be noted that a properly functioning overcurrent detector assumes the presence of a proper inductor or power ferrite bead at the power-stage output. Short-circuit protection is not guaranteed with direct short at the output pins of the power stage.

For normal operation, inductance in motor (assume larger than 10  $\mu$ H) is sufficient to provide low di/dt output (for example, for EMI) and proper protection during overload condition (CBC current limiting feature). So no additional output inductors are needed during normal operation.

However during a short condition, the motor (or other load) is shorted, so the load inductance is not present in the system anymore; the current in the device can reach such a high level that may exceed the abs max current rating due to extremely low impendence in the short circuit path and high di/dt before oc detection circuit kicks in. So a ferrite bead or inductor is recommended to use the short-circuit protection feature in DRV841x2. With an external inductance or ferrite bead, the current will rise at a much slower rate and reach a lower current level before oc protection starts. The device will then either operate CBC current limit or OC shut down automatically (when current is well above the current limit threshold) to protect the system.

For a system that has limited space, a power ferrite bead can be used instead of an inductor. The current rating of ferrite bead has to be higher than the RMS current of the system at normal operation. A ferrite bead designed for very high frequency is NOT recommended. A minimum impedance of 10  $\Omega$  or higher is recommended at 10 MHz or lower frequency to effectively limit the current rising rate during short circuit condition.

The TDK MPZ2012S300A (with size of 0805 inch type) have been tested in our system to meet a short circuit condition in the DRV8412. But other ferrite beads that have similar frequency characteristics can be used as well.

For higher power applications, such as in the DRV8432, there might be limited options to select suitable ferrite bead with high current rating. If an adequate ferrite bead cannot be found, an inductor can be used.

The inductance can be calculated as:

$$Loc\_min = \frac{PVDD \cdot Toc\_delay}{Ipeak - lave}$$

where

Toc\_delay = 250 nS

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## Feature Description (continued)

• Ipeak = 15 A (below abs max rating)

Because an inductor usually saturates after reaching its current rating, it is recommended to use an inductor with a doubled value or an inductor with a current rating well above the operating condition.

Inresnoid						
MAXIMUM CURRENT BEFORE OC OCCURS (A)						
11.6						
10.7						
9.7						
8.8						
7.4						
6.9						
6.3						
5.8						
4.9						
4.1						
3.4						
2.8						
2.4						
1.9						
1.4						

# Table 2. Programming-Resistor Values and OC Threshold

(1) Recommended to use in OC Latching Mode Only

## 7.3.2.3 Overtemperature Protection

The DRV841x2 has a two-level temperature-protection system that asserts an active-low warning signal (OTW) when the device junction temperature exceeds 125°C (nominal) and, if the device junction temperature exceeds 150°C (nominal), the device is <u>put into</u> thermal shutdown, resulting in all half-bridge outputs being <u>set in the</u> highimpedance (Hi-Z) state and FAULT being asserted low. OTSD is latched in this case and RESET\_AB and RESET\_CD must be asserted low to clear the latch.

## 7.3.2.4 Undervoltage Protection (UVP) and Power-On Reset (POR)

The UVP and POR circuits of the DRV841x2 fully protect the device in any power-up/down and brownout situation. While powering up, the POR circuit resets the overcurrent circuit and ensures that all circuits are fully operational when the GVDD\_X and VDD supply voltages reach 9.8 V (typical). Although GVDD\_X and VDD are independently monitored, a supply voltage drop below the UVP threshold on any VDD or GVDD\_X pin results in all half-bridge outputs immediately being set in the high-impedance (Hi-Z) state and FAULT being asserted low. The device automatically resumes operation when all supply voltage on the bootstrap capacitors have increased above the UVP threshold.

## 7.3.3 Device Reset

Two reset pins are provided for independent control of half-bridges A/B and C/D. When RESET\_AB is asserted low, all fo<u>ur power-stage</u> FETs in half-bridges A and B are forced into a high-impedance (Hi-Z) state. Likewise, asserting RESET\_CD low forces all four power-stage FETs in half-bridges C and D into a high-impedance state. To accommodate bootstrap charging prior to switching start, asserting the reset inputs low enables weak pulldown of the half-bridge outputs.

A rising-edge transition on reset input allows the device to resume operation after a shut-down fault. For example, when either or both half-bridge A and B have OC shutdown, a low to high transition of RESET\_AB pin will clear the fault and FAULT pin; when either or both half-bridge C and D have OC shutdown, a low to high transition of RESET\_CD pin will clear the fault and FAULT pin as well. When an OTSD occurs, both RESET\_AB and RESET\_CD need to have a low to high transition to clear the fault and FAULT signal.

(1)



## 7.4 Device Functional Modes

The DRV841x2 supports four different modes of operation:

- 1. Dual full bridges (FB) (two PWM inputs each full bridge) or four half bridges (HB) with CBC current limit
- 2. Dual full bridges (two PWM inputs each full bridge) or four half bridges with OC latching shutdown (no CBC current limit)
- 3. Parallel full bridge (PFB) with CBC current limit
- 4. Dual full bridges (one PWM input each full bridge) with CBC current limit

In mode 1 and 2, PWM\_A controls half bridge A, PWM\_B controls half bridge B, and so forth Figure 8 shows an application example for full bridge mode operation.

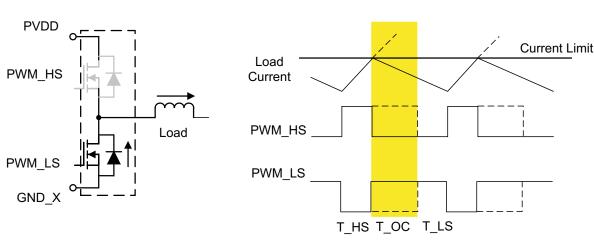
In parallel full bridge mode (mode 3), PWM\_A controls both half bridges A and B, and PWM\_B controls both half bridges C and D, while PWM\_C and PWM\_D pins are not used (recommended to connect to ground). Bridges A and B are synchronized internally (even during CBC), and so are bridges C and D. OUT\_A and OUT\_B should be connected together and OUT\_C and OUT\_D should be connected together after the output inductor or ferrite bead. If RESET\_AB or RESET\_CD are low, all four outputs become high-impedance. Figure 15 shows an example of parallel full bridge mode connection.

In mode 4, one PWM signal controls one full bridge to relieve some I/O resource from MCU, that is, PWM\_A controls half bridges A and B and PWM\_C controls half bridges C and D. In this mode, the operation of half bridge B is complementary to half bridge A, and the operation of half bridge D is complementary to half bridge C. For example, when PWM\_A is high, high side FET in half bridge A and low side FET in half bridge B will be on and low side FET in half bridge A and high side FET in half bridge B will be off. Since PWM\_B and PWM\_D pins are not used in this mode, it is recommended to connect them to ground.

In operation modes 1, 2, and 4 (CBC current limit is used), once the CBC current limit is hit, the driver will be deactivated until the next PWM cycle starts. However, in order for the output to be recovered, the PWM input corresponding to that driver in CBC must be toggled. Because of this, CBC mode does not support operation when one half-bridge PWM input is tied to dc logic level.

Because each half bridge has independent supply and ground pins, a shunt sensing resistor can be inserted between PVDD to PVDD\_X or GND\_X to GND (ground plane). A high side shunt resistor between PVDD and PVDD\_X is recommended for differential current sensing because a high bias voltage on the low side sensing could affect device operation. If low side sensing has to be used, a shunt resistor value of 10 m $\Omega$  or less or sense voltage 100 mV or less is recommended.

**CBC with High Side OC** 



Dashed line: normal operation; solid line: CBC event

During T\_OC Period

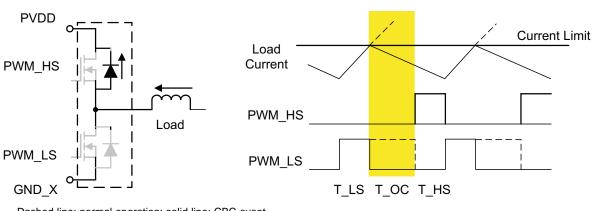
## Figure 6. Cycle-by-Cycle Operation With High-Side OC

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## During T\_OC Period

CBC with Low Side OC



Dashed line: normal operation; solid line: CBC event

## Figure 7. Cycle-by-Cycle Operation With Low-Side OC



## 8 Application and Implementation

## NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

## 8.1 Application Information

The DRV841x2 devices are typically used to drive 2 brushed DC or 1 stepper motor.

The DRV841x2 can be used for stepper motor applications as illustrated in Figure 16; they can be also used in three phase permanent magnet synchronous motor (PMSM) and sinewave brushless DC motor applications.

Figure 17 shows an example of a TEC driver application. The same configuration can also be used for DC output applications.

## 8.2 Typical Applications

## 8.2.1 Full Bridge Mode Operation

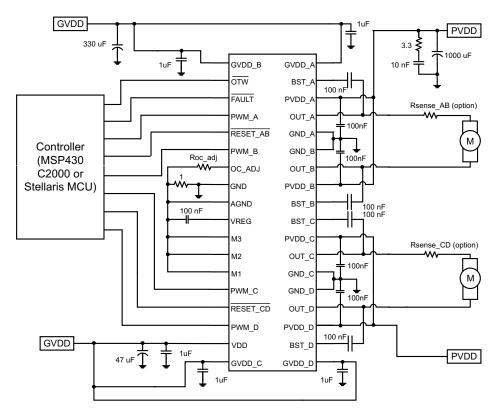


Figure 8. Application Diagram Example for Full Bridge Mode Operation Schematic

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## 8.2.1.1 Design Requirements

This section describes design considerations.

	-	
DESIGN PARAMETER	REFERENCE	EXAMPLE VALUE
Motor voltage	PVDD_x	24 V
Motor current (peak and RMS)	I <sub>PVDD</sub>	6-A peak, 3A RMS
Overcurrent threshold	OC <sub>TH</sub>	OC_ADJ = 27 kΩ, 9.7 A
Bridge mode	M1M2	Parallel full bridge

#### Table 3. Design Parameters

## 8.2.1.2 Detailed Design Procedure

#### 8.2.1.2.1 Motor Voltage

Higher voltages generally have the advantage of causing current to change faster through the inductive windings, which allows for higher RPMs. Lower voltages allow for more accurate control of phase currents.

#### 8.2.1.2.2 Current Requirement of 12-V Power Supply

The DRV83x2 requires a 12-V power supply for GVDD and VDD pins. The total supply current is relatively low at room temperature (less than 50 mA), but the current could increase significantly when the device temperature goes too high (for example, above 125°C), especially at heavy load conditions due to substrate current collection by 12-V guard rings. TI recommends designing the 12-V power supply with a current capability at least 5-10% of the load current, and no less than 100 mA to assure the device performance across all temperature ranges.

#### 8.2.1.2.3 Voltage of Decoupling Capacitor

The voltage of the decoupling capacitors should be selected in accordance with good design practices. Temperature, ripple current, and voltage overshoot must be considered. The high frequency decoupling capacitor should use ceramic capacitor with X5R or better rating. For a 50-V application, a minimum voltage rating of 63 V is recommended.

## 8.2.1.2.4 Overcurrent Threshold

When choosing the resistor value for OC\_ADJ, consider the peak current allowed under normal system behavior, the resistor tolerance, and that the Table 2 currents have a  $\pm 10\%$  tolerance. For example, if 6 A is the highest system current allowed across all normal behavior, a 27-k $\Omega$  OC\_ADJ resistor with 10% tolerance is a reasonable choice, as it would set the OC<sub>TH</sub> to approximately 8 A to 12 A.

## 8.2.1.2.5 Sense Resistor

For optimal performance, the sense resistor must be:

- Surface-mount
- Low inductance
- Rated for high enough power
- · Placed closely to the motor driver

The power dissipated by the sense resistor equals  $I_{RMS}^2 \times R$ . For example, if peak motor current is 3 A, RMS motor current is 2 A, and a 0.05- $\Omega$  sense resistor is used, the resistor will dissipate 2 A<sup>2</sup> × 0.05  $\Omega$  = 0.2 W. The power increases quickly with higher current levels.

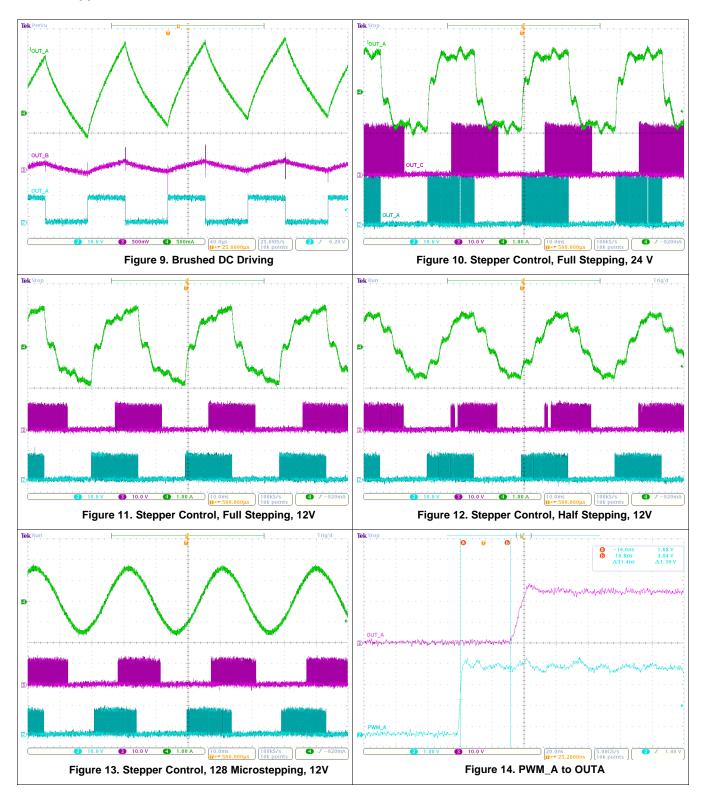
Resistors typically have a rated power within some ambient temperature range, along with a de-rated power curve for high ambient temperatures. When a PCB is shared with other components generating heat, margin should be added. Always measure the actual sense resistor temperature in a final system, along with the power MOSFETs, as those are often the hottest components.

Because power resistors are larger and more expensive than standard resistors, use multiple standard resistors in parallel, between the sense node and ground. This distributes the current and heat dissipation.

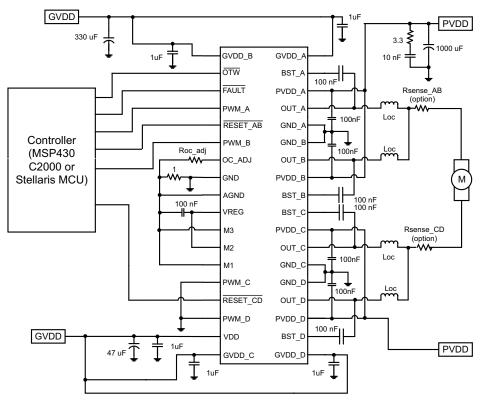
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#### 8.2.1.3 Application Curves



## 8.2.2 Parallel Full Bridge Mode Operation



PWM\_A controls OUT\_A and OUT\_B; PWM\_B controls OUT\_C and OUT\_D.

Figure 15. Application Diagram Example for Parallel Full Bridge Mode Operation Schematic



## 8.2.3 Stepper Motor Operation

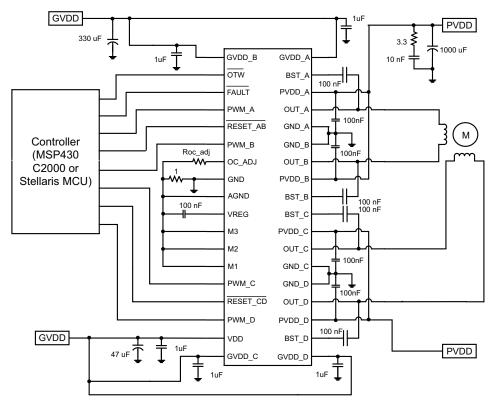


Figure 16. Application Diagram Example for Stepper Motor Operation Schematic

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## 8.2.4 TEC Driver

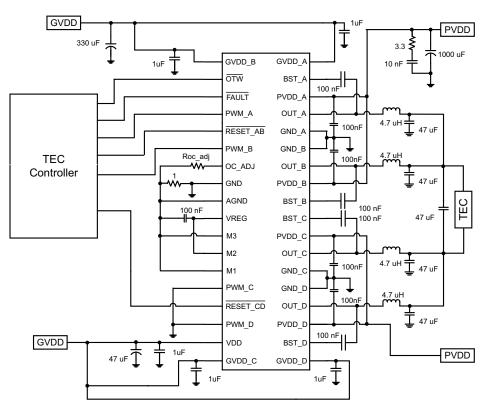


Figure 17. Application Diagram Example for TEC Driver Schematic



## 8.2.5 LED Lighting Driver

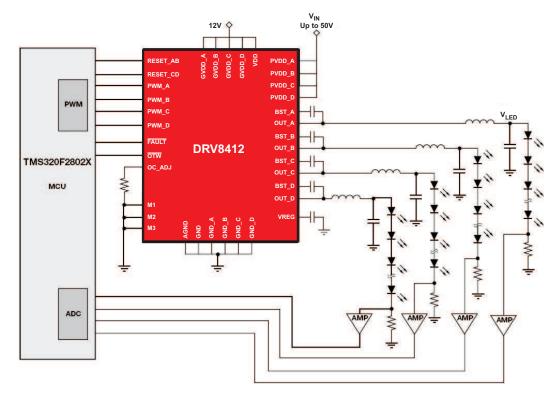


Figure 18. Application Diagram Example for LED Lighting Driver Schematic

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## 9 Power Supply Recommendations

## 9.1 Bulk Capacitance

Having an appropriate local bulk capacitance is an important factor in motor drive system design. It is generally beneficial to have more bulk capacitance, while the disadvantages are increased cost and physical size.

The amount of local capacitance needed depends on a variety of factors, including:

- The highest current required by the motor system
- The power supply's capacitance and ability to source current
- · The amount of parasitic inductance between the power supply and motor system
- The acceptable voltage ripple
- The type of motor used (Brushed DC, Brushless DC, Stepper)
- The motor braking method

The inductance between the power supply and the motor drive system limits the rate current can change from the power supply. If the local bulk capacitance is too small, the system responds to excessive current demands or dumps from the motor with a change in voltage. When adequate bulk capacitance is used, the motor voltage remains stable and high current can be quickly supplied.

The data sheet generally provides a recommended value, but system-level testing is required to determine the appropriate sized bulk capacitor.

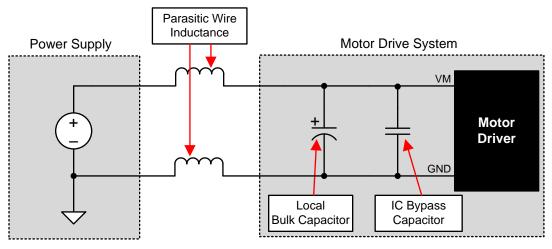


Figure 19. Example Setup of Motor Drive System With External Power Supply

The voltage rating for bulk capacitors should be higher than the operating voltage, to provide margin for cases when the motor transfers energy to the supply.

## 9.2 **Power Supplies**

To facilitate system design, the DRV841x2 needs only a 12-V supply in addition to H-Bridge power supply (PVDD). An internal voltage regulator provides suitable voltage levels for the digital and low-voltage analog circuitry. Additionally, the high-side gate drive requires a floating voltage supply, which is accommodated by built-in bootstrap circuitry requiring external bootstrap capacitor.

To provide symmetrical electrical characteristics, the PWM signal path, including gate drive and output stage, is designed as identical, independent half-bridges. For this reason, each half-bridge has a separate gate drive supply (GVDD\_X), a bootstrap pin (BST\_X), and a power-stage supply pin (PVDD\_X). Furthermore, an additional pin (VDD) is provided as supply for all common circuits. Special attention should be paid to place all decoupling capacitors as close to their associated pins as possible. In general, inductance between the power supply pins and decoupling capacitors must be avoided. Furthermore, decoupling capacitors need a short ground path back to the device.



## **Power Supplies (continued)**

For a properly functioning bootstrap circuit, a small ceramic capacitor (an X5R or better) must be connected from each bootstrap pin (BST\_X) to the power-stage output pin (OUT\_X). When the power-stage output is low, the bootstrap capacitor is charged through an internal diode connected between the gate-drive power-supply pin (GVDD\_X) and the bootstrap pin. When the power-stage output is high, the bootstrap capacitor potential and thus provides a suitable voltage supply for the high-side gate driver. In an application with PWM switching frequencies in the range from 10 kHz to 500 kHz, the use of 100-nF ceramic capacitors (X5R or better), size 0603 or 0805, is recommended for the bootstrap supply. These 100-nF capacitors ensure sufficient energy storage, even during minimal PWM duty cycles, to keep the high-side power stage FET fully turned on during the remaining part of the PWM cycle. In an application running at a switching frequency lower than 10 kHz, the bootstrap capacitor might need to be increased in value.

Special attention should be paid to the power-stage power supply; this includes component selection, PCB placement, and routing. As indicated, each half-bridge has independent power-stage supply pin (PVDD\_X). For optimal electrical performance, EMI compliance, and system reliability, it is important that each PVDD\_X pin is decoupled with a ceramic capacitor (X5R or better) placed as close as possible to each supply pin. It is recommended to follow the PCB layout of the DRV841x2 EVM board.

The 12-V supply should be from a low-noise, low-output-impedance voltage regulator. Likewise, the 50-V powerstage supply is assumed to have low output impedance and low noise. The power-supply sequence is not critical as facilitated by the internal power-on-reset circuit. Moreover, the DRV841x2 is fully protected against erroneous power-stage turn-on due to parasitic gate charging. Thus, voltage-supply ramp rates (dv/dt) are non-critical within the specified voltage range (see *Recommended Operating Conditions* of this data sheet).

## 9.3 System Power-Up and Power-Down Sequence

## 9.3.1 Powering Up

The DRV841x2 does not require a power-up sequence. The outputs of the H-bridges remain in a high impedance state until the gate-drive supply voltage GVDD\_X and VDD voltage are above the undervoltage protection (UVP) voltage threshold (see the *Electrical Characteristics* section of this data sheet). Although not specifically required, holding RESET\_AB and RESET\_CD in a low state while powering up the device is recommended. This allows an internal circuit to charge the external bootstrap capacitors by enabling a weak pulldown of the half-bridge output.

## 9.3.2 Powering Down

The DRV841x2 does not require a power-down sequence. The device remains fully operational as long as the gate-drive supply (GVDD\_X) voltage and VDD voltage are above the UVP voltage threshold (see the *Electrical Characteristics* section of this data sheet). Although not specifically required, it is a good practice to hold RESET\_AB and RESET\_CD low during power down to prevent any unknown state during this transition.

## 9.4 System Design Recommendations

## 9.4.1 VREG Pin

The VREG pin is used for internal logic and not recommended to be used as a voltage source for external circuitry.

## 9.4.2 VDD Pin

The transient current in VDD pin could be significantly higher than average current through that pin. A low resistive path to GVDD should be used. A  $22-\mu$ F to  $47-\mu$ F capacitor should be placed on VDD pin beside the 100-nF to  $1-\mu$ F decoupling capacitor to provide a constant voltage during transient.

## 9.4.3 OTW Pin

OTW reporting indicates the device approaching high junction temperature. This signal can be used with MCU to decrease system power when OTW is low in order to prevent OT shut down at a higher temperature.

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## System Design Recommendations (continued)

## 9.4.4 Mode Select Pin

Mode select pins (M1, M2, and M3) should be connected to either VREG (for logic high) or AGND for logic low. It is not recommended to connect mode pins to board ground if  $1-\Omega$  resistor is used between AGND and GND.

#### 9.4.5 Parallel Mode Operation

For a device operated in parallel mode, a minimum of 30 nH to 100 nH inductance or a ferrite bead is required after the output pins (for example, OUT\_A and OUT\_B) before connecting the two channels together. This will help to prevent any shoot through between two paralleled channels during switching transient due to mismatch of paralleled channels (for example, processor variation, unsymmetrical PCB layout, etc).

#### 9.4.6 **TEC Driver Application**

For TEC driver or other non-motor related applications (for example, resistive load or dc output), a low-pass LC filter can be used to meet the requirement.



## 10 Layout

## 10.1.1 PCB Material Recommendation

FR-4 Glass Epoxy material with 2 oz. copper on both top and bottom layer is recommended for improved thermal performance (better heat sinking) and less noise susceptibility (lower PCB trace inductance).

## 10.1.2 Ground Plane

Because of the power level of these devices, it is recommended to use a big unbroken single ground plane for the whole system / board. The ground plane can be easily made at bottom PCB layer. In order to minimize the impedance and inductance of ground traces, the traces from ground pins should keep as short and wide as possible before connected to bottom ground plane through vias. Multiple vias are suggested to reduce the impedance of vias. Try to clear the space around the device as much as possible especially at bottom PCB side to improve the heat spreading.

## 10.1.3 Decoupling Capacitor

High frequency decoupling capacitors (100 nF) on PVDD\_X pins should be placed close to these pins and with a short ground return path to minimize the inductance on the PCB trace.

## 10.1.4 AGND

AGND is a localized internal ground for logic signals. A  $1-\Omega$  resistor is recommended to be connected between GND and AGND to isolate the noise from board ground to AGND. There are other two components are connected to this local ground:  $0.1-\mu$ F capacitor between VREG to AGND and Roc\_adj resistor between OC\_ADJ and AGND. Capacitor for VREG should be placed close to VREG and AGND pin and connected without vias.

## 10.2 Layout Example

#### 10.2.1 Current Shunt Resistor

If current shunt resistor is connected between GND\_X to GND or PVDD\_X to PVDD, make sure there is only one single path to connect each GND\_X or PVDD\_X pin to shunt resistor, and the path is short and symmetrical on each sense path to minimize the measurement error due to additional resistance on the trace.

An example of the schematic and PCB layout of DRV8412 are shown in Figure 20, Figure 21, and Figure 22.

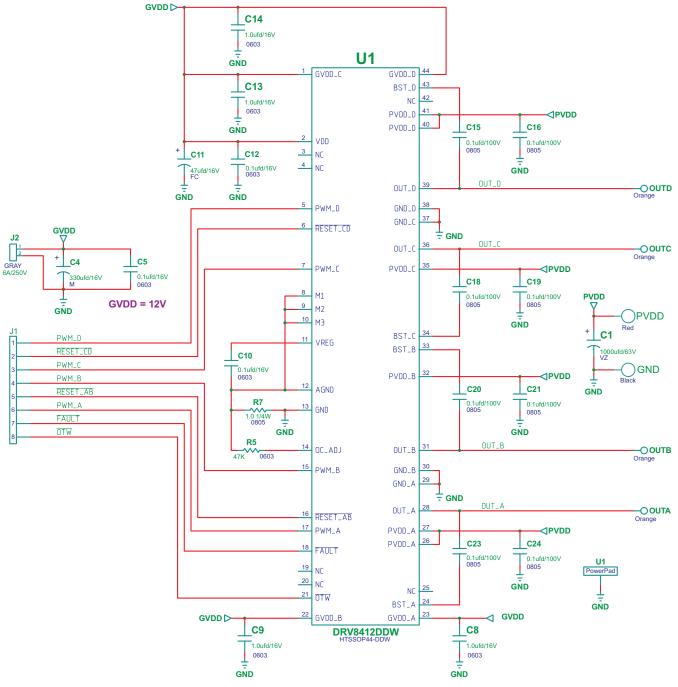
DRV8412, DRV8432

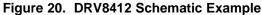
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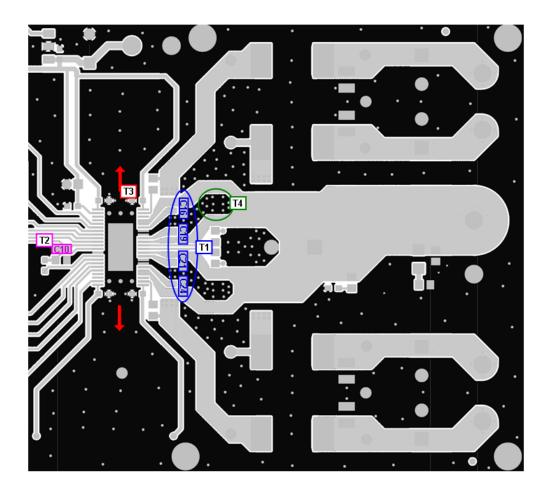
## Layout Example (continued)







## Layout Example (continued)



T1: PVDD decoupling capacitors C16, C19, C21, and C24 should be placed very close to PVDD\_X pins and ground return path.

T2: VREG decoupling capacitor C10 should be placed very close to VREG abd AGND pins.

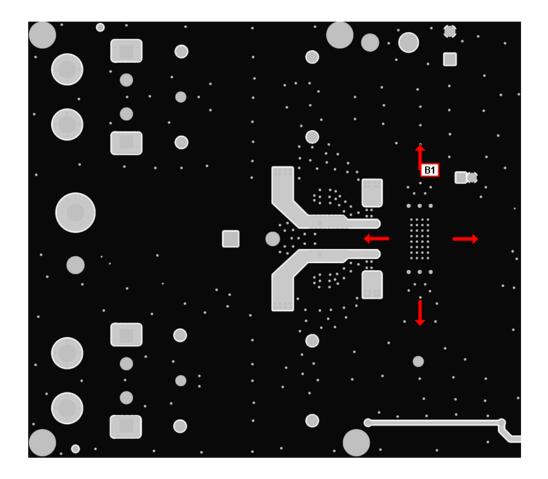
T3: Clear the space above and below the device as much as possible to improve the thermal spreading.

T4: Add many vias to reduce the impedance of ground path through top to bottom side. Make traces as wide as possible for ground path such as GND\_X path.

Figure 21. Printed Circuit Board – Top Layer



## Layout Example (continued)



B1: Do not block the heat transfer path at bottom side. Clear as much space as possible for better heat spreading.

## Figure 22. Printed Circuit Board – Bottom Layer

## **10.3 Thermal Considerations**

The thermally enhanced package provided with the DRV8432 is designed to interface directly to heat sink using a thermal interface compound, (for example, Ceramique from Arctic Silver, TIMTronics 413, and so forth). The heat sink then absorbs heat from the ICs and couples it to the local air. It is also a good practice to connect the heatsink to system ground on the PCB board to reduce the ground noise.

 $R_{\theta JA}$  is a system thermal resistance from junction to ambient air. As such, it is a system parameter with the following components:

- R<sub>0.JC</sub> (the thermal resistance from junction to case, or in this example the power pad or heat slug)
- Thermal grease thermal resistance
- Heat sink thermal resistance



## **Thermal Considerations (continued)**

The thermal grease thermal resistance can be calculated from the exposed power pad or heat slug area and the thermal grease manufacturer's area thermal resistance (expressed in °C-in<sup>2</sup>/W or °C-mm<sup>2</sup>/W). The approximate exposed heat slug size is as follows:

• DRV8432, 36-pin PSOP3 ..... 0.124 in<sup>2</sup> (80 mm<sup>2</sup>)

The thermal resistance of thermal pads is considered higher than a thin thermal grease layer and is not recommended. Thermal tape has an even higher thermal resistance and should not be used at all. Heat sink thermal resistance is predicted by the heat sink vendor, modeled using a continuous flow dynamics (CFD) model, or measured.

Thus the system  $R_{\theta JA} = R_{\theta JC}$  + thermal grease resistance + heat sink resistance.

See the TI application report, IC Package Thermal Metrics (SPRA953), for more thermal information.

## 10.3.1 DRV8412 Thermal Via Design Recommendation

Thermal pad of the DRV8412 is attached at bottom of device to improve the thermal capability of the device. The thermal pad has to be soldered with a very good coverage on PCB in order to deliver the power specified in the datasheet. The figure below shows the recommended thermal via and land pattern design for the DRV8412. For additional information, see TI application report, PowerPad Made Easy (SLMA004) and PowerPad Layout Guidelines (SOLA120).

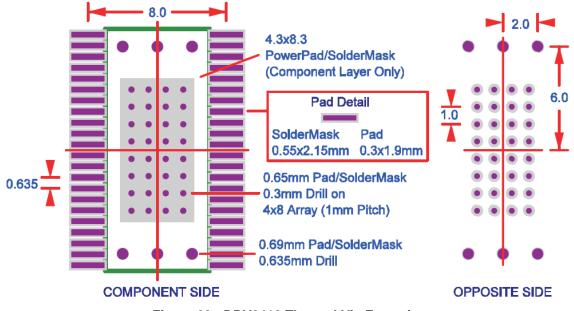


Figure 23. DRV8412 Thermal Via Footprint

# 11 Device and Documentation Support

## 11.1 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
DRV8412	Click here	Click here	Click here	Click here	Click here
DRV8432	Click here	Click here	Click here	Click here	Click here

## Table 4. Related Links

## 11.2 Trademarks

All trademarks are the property of their respective owners.

## 11.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## 11.4 Glossary

## SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

## 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.





7-Jul-2014

## **PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
DRV8412DDW	ACTIVE	HTSSOP	DDW	44	35	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 85	DRV8412	Samples
DRV8412DDWR	ACTIVE	HTSSOP	DDW	44	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 85	DRV8412	Samples
DRV8432DKD	ACTIVE	HSSOP	DKD	36	29	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-4-260C-72 HR	-40 to 85	DRV8432	Samples
DRV8432DKDR	ACTIVE	HSSOP	DKD	36	500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-4-260C-72 HR	-40 to 85	DRV8432	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.



7-Jul-2014

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# PACKAGE MATERIALS INFORMATION

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## TAPE AND REEL INFORMATION





## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nomina	al											
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DRV8412DDWR	HTSSOP	DDW	44	2000	330.0	24.4	8.6	15.6	1.8	12.0	24.0	Q1
DRV8432DKDR	HSSOP	DKD	36	500	330.0	24.4	14.7	16.4	4.0	20.0	24.0	Q1

TEXAS INSTRUMENTS

www.ti.com

# PACKAGE MATERIALS INFORMATION

20-Aug-2014

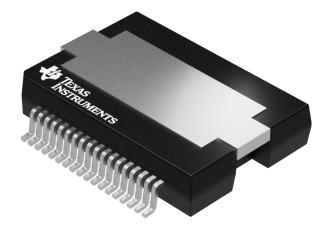


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
DRV8412DDWR	HTSSOP	DDW	44	2000	367.0	367.0	45.0
DRV8432DKDR	HSSOP	DKD	36	500	367.0	367.0	45.0

## **GENERIC PACKAGE VIEW**

# PowerPAD<sup>™</sup> SSOP - 3.6 mm max height PLASTIC SMALL OUTLINE



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



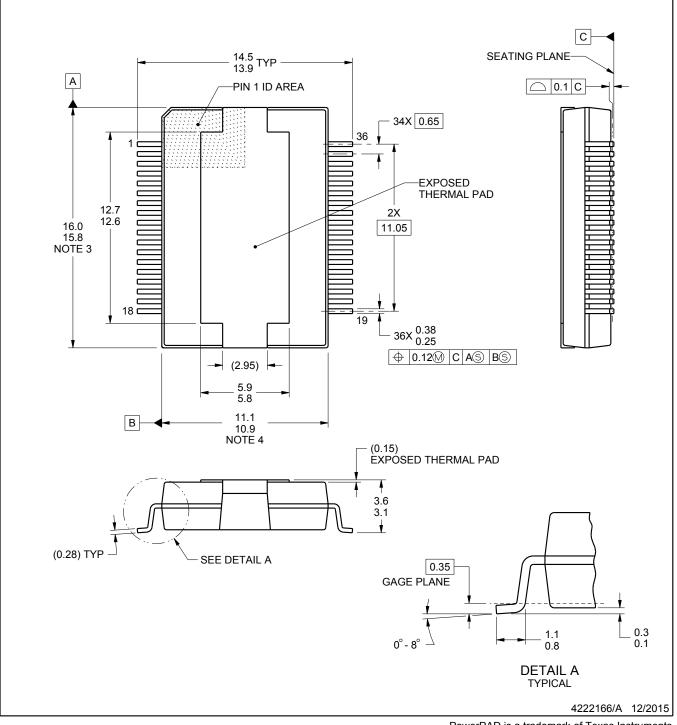
4204421-2/N

# **PACKAGE OUTLINE**

# **DKD0036A**

## PowerPAD<sup>™</sup> SSOP - 3.6 mm max height

PLASTIC SMALL OUTLINE



NOTES:

PowerPAD is a trademark of Texas Instruments.

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
- 4. The exposed thermal pad is designed to be attached to an external heatsink.

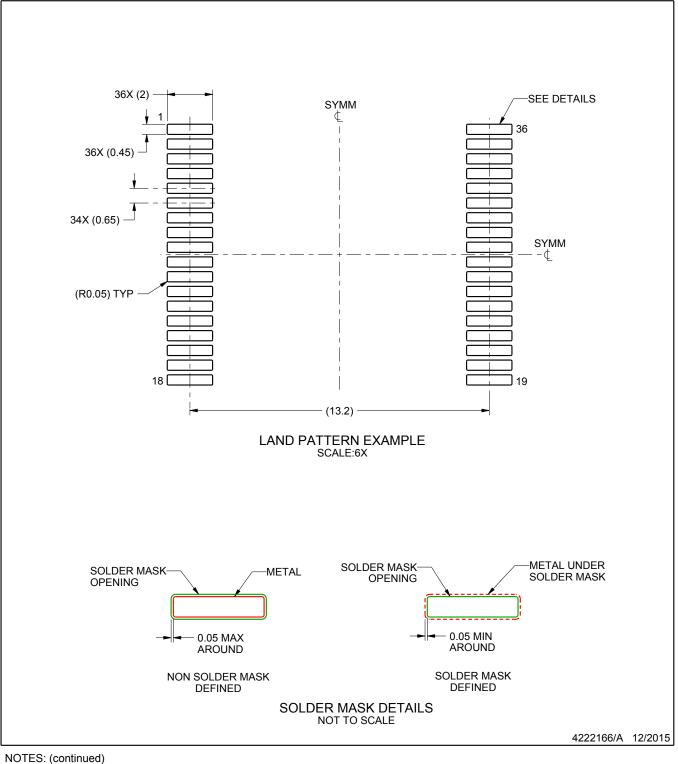


# **DKD0036A**

# **EXAMPLE BOARD LAYOUT**

## PowerPAD<sup>™</sup> SSOP - 3.6 mm max height

PLASTIC SMALL OUTLINE



5. Publication IPC-7351 may have alternate designs.

6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

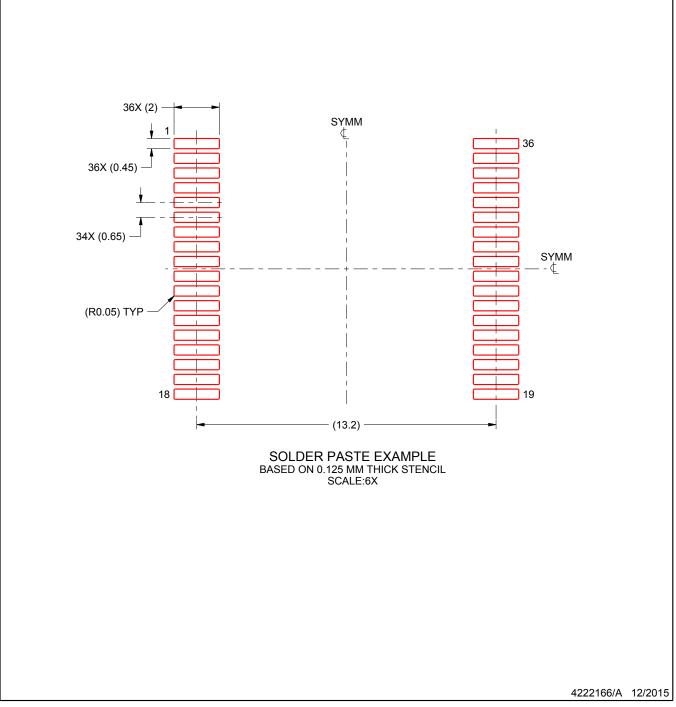


# **DKD0036A**

# **EXAMPLE STENCIL DESIGN**

# PowerPAD<sup>™</sup> SSOP - 3.6 mm max height

PLASTIC SMALL OUTLINE



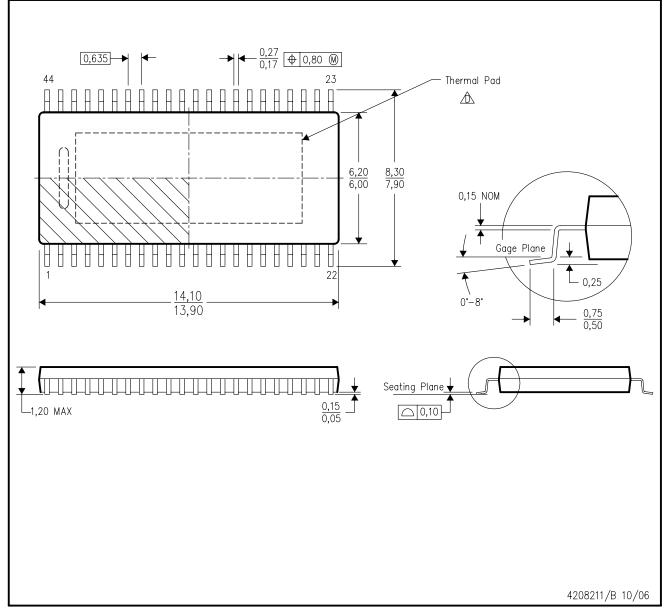
NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations. 8. Board assembly site may have different recommendations for stencil design.



DDW (R-PDSO-G44) PowerPAD <sup>™</sup>PLASTIC

PowerPAD <sup>™</sup>PLASTIC SMALL-OUTLINE PACKAGE (PAD DOWN)



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

This package thermal performance is optimized for conductive cooling with attachment to an external heat sink. See the product data sheet for details regarding the exposed thermal pad dimensions.

PowerPAD is a trademark of Texas Instruments.



# THERMAL PAD MECHANICAL DATA

## DDW (R-PDSO-G44)

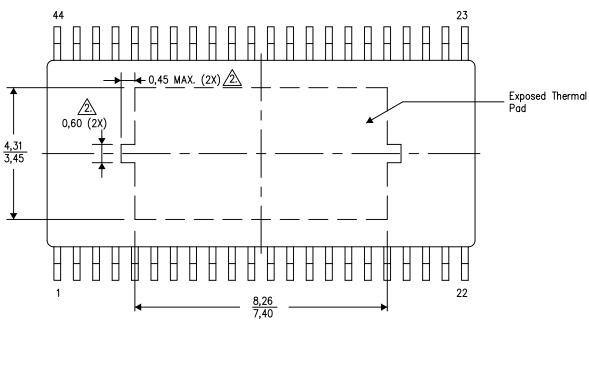
# PowerPAD<sup>™</sup> SMALL OUTLINE PACKAGE

## THERMAL INFORMATION

This PowerPAD<sup>™</sup> package incorporates an exposed thermal pad that is designed to be attached to a printed circuit board (PCB). The thermal pad must be soldered directly to the PCB. After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For additional information on the PowerPAD package and how to take advantage of its heat dissipating abilities, refer to Technical Brief, PowerPAD Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 and Application Brief, PowerPAD Made Easy, Texas Instruments Literature No. SLMA004. Both documents are available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



#### Top View



1. All linear dimensions are in millimeters These features may not be present.

Exposed Thermal Pad Dimensions



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